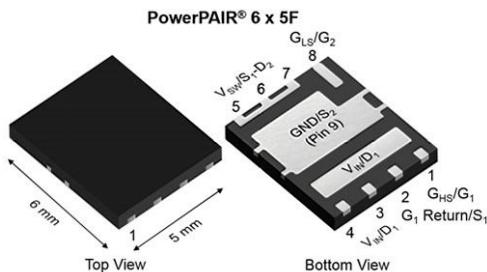


Dual N-Channel 25 V (D-S) MOSFET with Schottky Diode



FEATURES

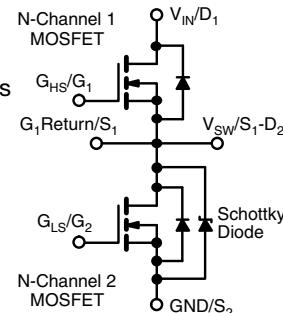
- TrenchFET® Gen IV power MOSFET
- SkyFET® low side MOSFET with integrated Schottky
- G₁ return/S₁ pin for enhancing high side driving
- 100 % R_g and UIS tested
- Material categorization: for definitions of compliance please see www.vishay.com/doc?99912



RoHS
COMPLIANT
HALOGEN
FREE

APPLICATIONS

- CPU core power
- Computer / server peripherals
- POL
- Synchronous buck converter
- Telecom DC/DC



PRODUCT SUMMARY

	CHANNEL-1	CHANNEL-2
V _{DS} (V)	25	25
R _{DS(on)} max. (Ω) at V _{GS} = 10 V	0.00380	0.00090
R _{DS(on)} max. (Ω) at V _{GS} = 4.5 V	0.00620	0.00150
Q _g typ. (nC)	6.6	31
I _D (A) ^a	40	60
Configuration	Dual	

ORDERING INFORMATION

Package	PowerPAIR 6 x 5F
Lead (Pb)-free and halogen-free	SiZF914DT-T1-GE3

ABSOLUTE MAXIMUM RATINGS (T_A = 25 °C, unless otherwise noted)

PARAMETER	SYMBOL	CHANNEL-1		CHANNEL-2	UNIT	
		TYP.	MAX.			
Drain-source voltage	V _{DS}	25	25		V	
Gate-source voltage	V _{GS}	+20, -16	+16, -12			
Continuous drain current (T _J = 150 °C)	I _D	40 ^a	60 ^a		A	
		40 ^a	60 ^a			
		23.5 ^{b, c}	52 ^{b, c}			
		19 ^{b, c}	42 ^{b, c}			
Pulsed drain current (t = 100 μs)	I _{DM}	130	110			
Continuous source-drain diode current	I _S	22	60 ^a			
		2.8 ^{b, c}	6.7 ^{b, c}			
Single pulse avalanche current	I _{AS}	20	34			
Single pulse avalanche energy	E _{AS}	20	58		mJ	
Maximum power dissipation	P _D	26.6	60		W	
		17	38			
		3.4 ^{b, c}	4 ^{b, c}			
		2.2 ^{b, c}	2.6 ^{b, c}			
Operating junction and storage temperature range	T _J , T _{stg}	-55 to +150			°C	
Soldering recommendations (peak temperature) ^{d, e}		260				

THERMAL RESISTANCE RATINGS

PARAMETER	SYMBOL	CHANNEL-1		CHANNEL-2		UNIT
		TYP.	MAX.	TYP.	MAX.	
Maximum junction-to-ambient ^{b, f}	t ≤ 10 s	R _{thJA}	30	37	25	31
Maximum junction-to-case (source)	Steady state	R _{thJC}	3.8	4.7	1.7	2.1

Notes

- Package limited
- Surface mounted on 1" x 1" FR4 board
- t = 10 s
- See solder profile (www.vishay.com/doc?73257). The PowerPAIR is a leadless package. The end of the lead terminal is exposed copper (not plated) as a result of the singulation process in manufacturing. A solder fillet at the exposed copper tip cannot be guaranteed and is not required to ensure adequate bottom side solder interconnection
- Rework conditions: manual soldering with a soldering iron is not recommended for leadless components
- Maximum under steady state conditions is 77 °C/W for channel-1 and 68 °C/W for channel-2

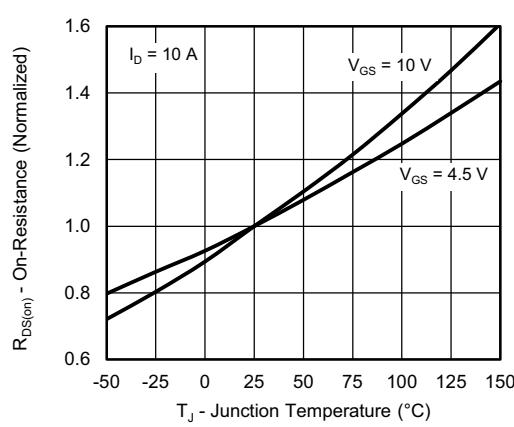
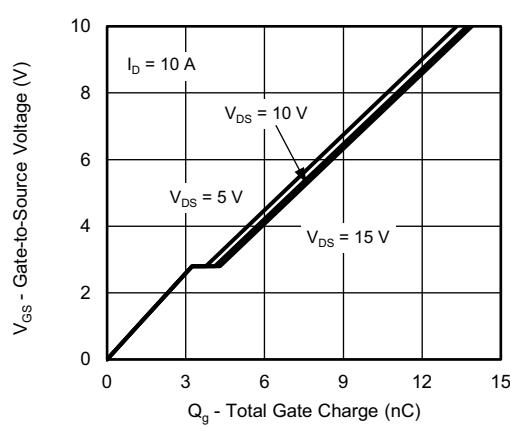
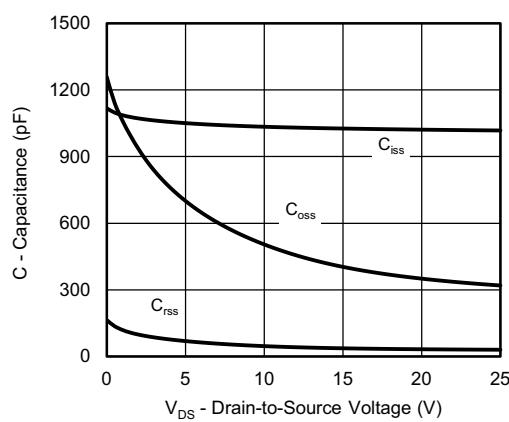
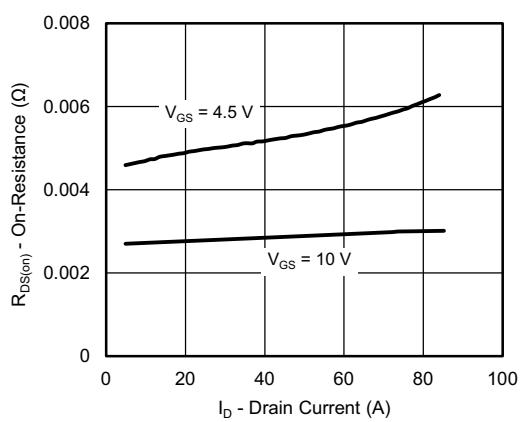
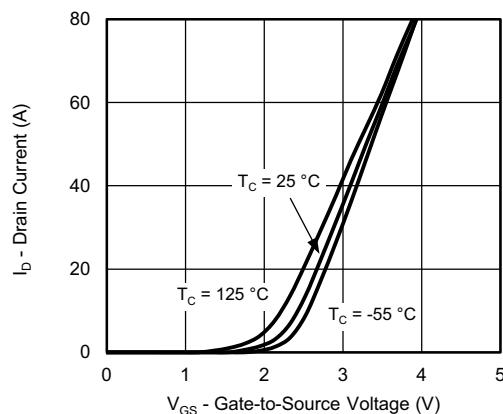
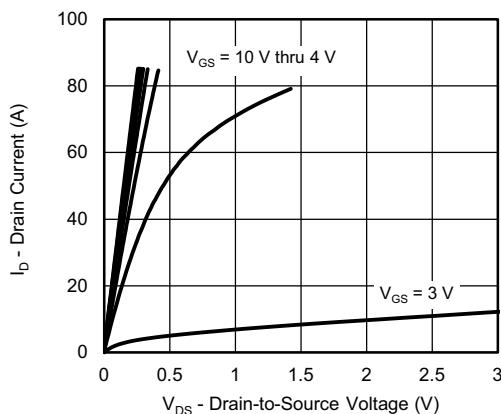
SPECIFICATIONS ($T_J = 25^\circ\text{C}$, unless otherwise noted)								
PARAMETER	SYMBOL	TEST CONDITIONS			MIN.	TYP.	MAX.	UNIT
Static								
Drain-source breakdown voltage	V_{DS}	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$	Ch-1	25	-	-	V	
			Ch-2	25	-	-		
Gate-source threshold voltage	$V_{GS(\text{th})}$	$V_{DS} = V_{GS}, I_D = 250 \mu\text{A}$	Ch-1	1.1	-	2.4		
			Ch-2	1.1	-	2.2		
Gate-source leakage	I_{GSS}	$V_{DS} = 0 \text{ V}, V_{GS} = +20 \text{ V}, -16 \text{ V}$	Ch-1	-	-	± 100	nA	
		$V_{DS} = 0 \text{ V}, V_{GS} = +16 \text{ V}, -12 \text{ V}$	Ch-2	-	-	± 100		
Zero Gate voltage drain current	I_{DSS}	$V_{DS} = 25 \text{ V}, V_{GS} = 0 \text{ V}$	Ch-1	-	-	1	μA	
			Ch-2	-	30	350		
		$V_{DS} = 25 \text{ V}, V_{GS} = 0 \text{ V}, T_J = 55^\circ\text{C}$	Ch-1	-	-	5		
			Ch-2	-	200	3000		
On-state drain current ^b	$I_{D(on)}$	$V_{DS} \geq 5 \text{ V}, V_{GS} = 10 \text{ V}$	Ch-1	20	-	-	A	
			Ch-2	20	-	-		
Drain-source on-state resistance ^b	$R_{DS(on)}$	$V_{GS} = 10 \text{ V}, I_D = 10 \text{ A}$	Ch-1	-	0.00270	0.00380	Ω	
		$V_{GS} = 10 \text{ V}, I_D = 10 \text{ A}$	Ch-2	-	0.00060	0.00090		
		$V_{GS} = 4.5 \text{ V}, I_D = 5 \text{ A}$	Ch-1	-	0.00410	0.00620		
		$V_{GS} = 4.5 \text{ V}, I_D = 5 \text{ A}$	Ch-2	-	0.00095	0.00150		
Forward transconductance ^b	g_{fs}	$V_{DS} = 10 \text{ V}, I_D = 20 \text{ A}$	Ch-1	-	45	-	S	
		$V_{DS} = 10 \text{ V}, I_D = 20 \text{ A}$	Ch-2	-	105	-		
Dynamic ^a								
Input capacitance	C_{iss}	Channel-1 $V_{DS} = 10 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$	Ch-1	-	1050	-	pF	
Output capacitance	C_{oss}		Ch-2	-	4670	-		
Reverse transfer capacitance	C_{rss}		Ch-1	-	510	-		
C_{rss}/C_{iss} ratio			Ch-2	-	1650	-		
Total gate charge	Q_g		Ch-1	-	47	-		
Gate-source charge	Q_{gs}		Ch-2	-	370	-		
Gate-drain charge	Q_{gd}		Ch-1	-	0.036	0.072		
Output charge	Q_{oss}		Ch-2	-	0.062	0.125		
Gate resistance	R_g	$f = 1 \text{ MHz}$	Ch-1	-	14	21	Ω	
			Ch-2	-	65	98		
		Channel-1 $V_{DS} = 10 \text{ V}, V_{GS} = 4.5 \text{ V}, I_D = 10 \text{ A}$	Ch-1	-	6.6	10		
			Ch-2	-	31	47		
			Ch-1	-	3.2	-		
			Ch-2	-	10.2	-		
			Ch-1	-	1.2	-		
			Ch-2	-	6.4	-		
			Ch-1	-	7.5	-		
			Ch-2	-	27	-		

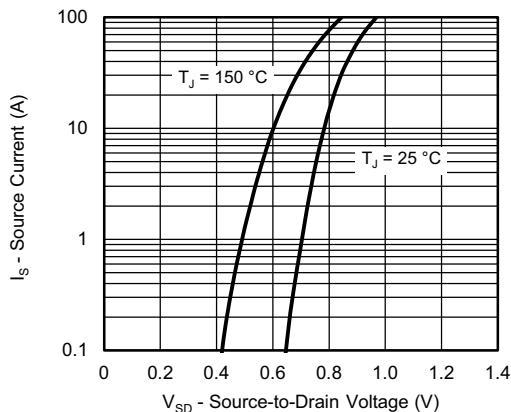
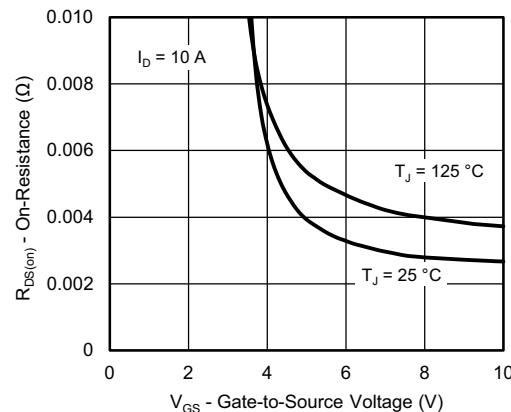
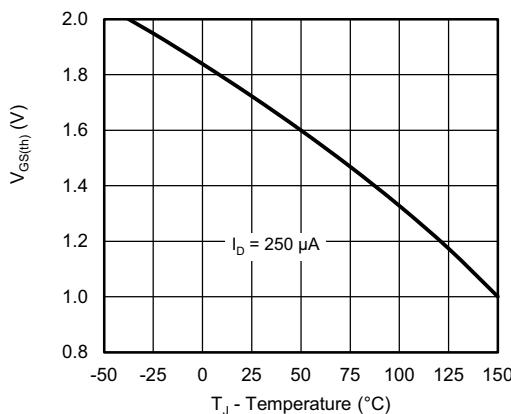
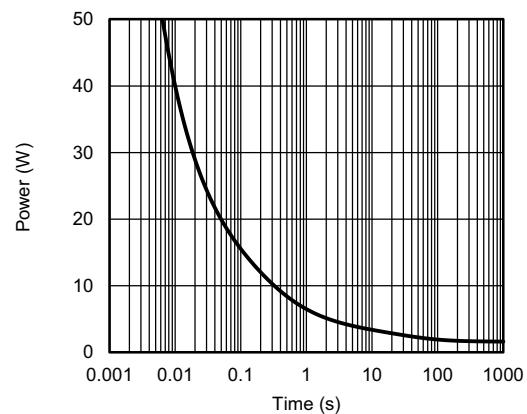
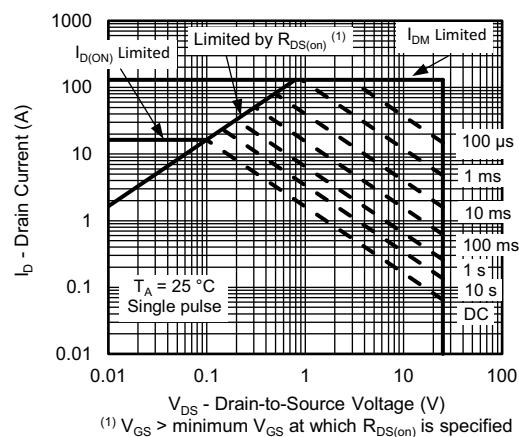
SPECIFICATIONS ($T_J = 25^\circ\text{C}$, unless otherwise noted)						
PARAMETER	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNIT
Dynamic ^a						
Turn-on delay time	$t_{d(on)}$	Channel-1 $V_{DD} = 10 \text{ V}$, $R_L = 2 \Omega$ $I_D \geq 5 \text{ A}$, $V_{GEN} = 4.5 \text{ V}$, $R_g = 1 \Omega$	Ch-1	-	20	40
Rise time	t_r		Ch-2	-	32	60
Turn-off delay time	$t_{d(off)}$		Ch-1	-	50	100
Fall time	t_f		Ch-2	-	60	120
Turn-on delay time	$t_{d(on)}$		Ch-1	-	15	30
Rise time	t_r		Ch-2	-	45	90
Turn-off delay time	$t_{d(off)}$		Ch-1	-	10	20
Fall time	t_f		Ch-2	-	15	30
Turn-on delay time	$t_{d(on)}$	Channel-1 $V_{DD} = 10 \text{ V}$, $R_L = 2 \Omega$ $I_D \geq 5 \text{ A}$, $V_{GEN} = 10 \text{ V}$, $R_g = 1 \Omega$	Ch-1	-	12	25
Rise time	t_r		Ch-2	-	16	30
Turn-off delay time	$t_{d(off)}$		Ch-1	-	5	10
Fall time	t_f		Ch-2	-	30	60
Turn-on delay time	$t_{d(on)}$		Ch-1	-	20	40
Rise time	t_r		Ch-2	-	40	80
Turn-off delay time	$t_{d(off)}$		Ch-1	-	5	10
Fall time	t_f		Ch-2	-	6	15
Drain-Source Body Diode Characteristics						
Continuous source-drain diode current	I_S	$T_C = 25^\circ\text{C}$	Ch-1	-	-	22
			Ch-2	-	-	60
Pulse diode forward current ^a	I_{SM}		Ch-1	-	-	130
			Ch-2	-	-	110
Body diode voltage	V_{SD}	$I_S = 5 \text{ A}$, $V_{GS} = 0 \text{ V}$	Ch-1	-	0.8	1.2
		$I_S = 3 \text{ A}$, $V_{GS} = 0 \text{ V}$	Ch-2	-	0.38	0.6
Body diode reverse recovery time	t_{rr}	Channel-1 $I_F = 5 \text{ A}$, $di/dt = 100 \text{ A}/\mu\text{s}$, $T_J = 25^\circ\text{C}$	Ch-1	-	36	70
Body diode reverse recovery charge	Q_{rr}		Ch-2	-	66	130
Reverse recovery fall time	t_a		Ch-1	-	36	50
Reverse recovery rise time	t_b		Ch-2	-	72	150
			Ch-1	-	20	-
			Ch-2	-	30	-
			Ch-1	-	16	-
			Ch-2	-	36	-

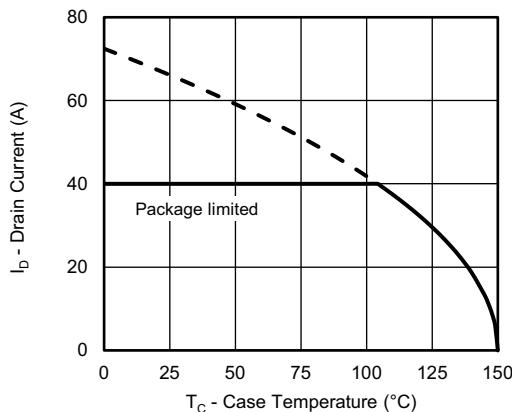
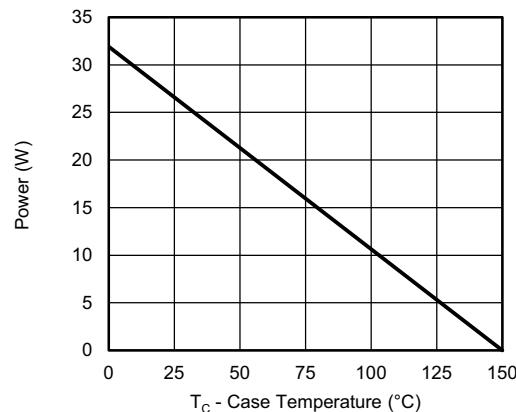
Notes

- a. Guaranteed by design, not subject to production testing
- b. Pulse test; pulse width $\leq 300 \mu\text{s}$, duty cycle $\leq 2\%$

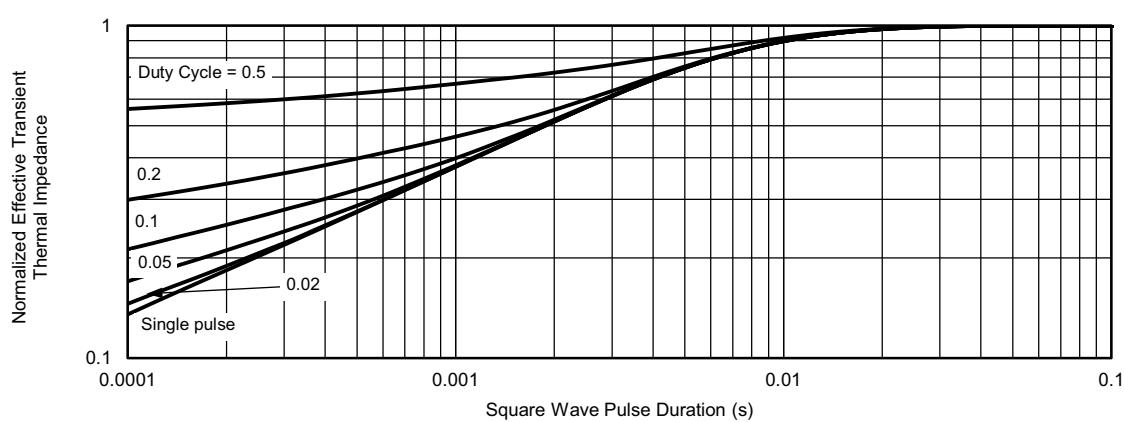
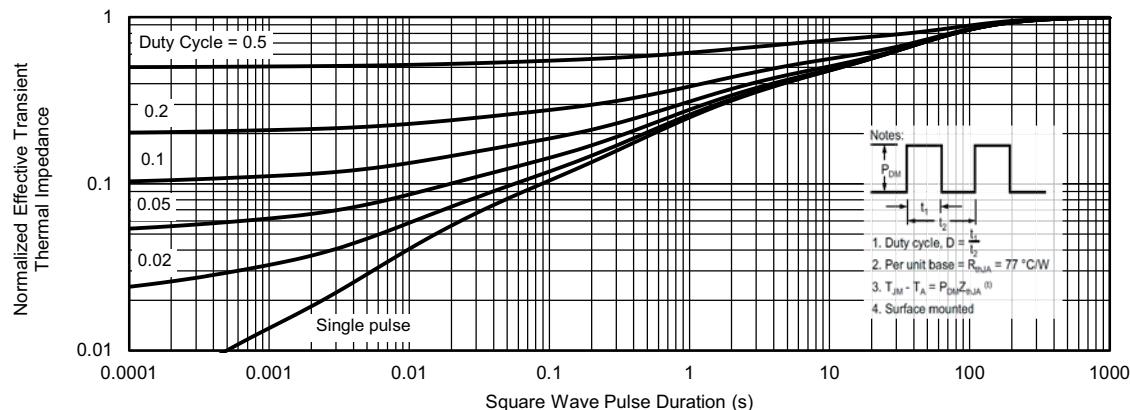
Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

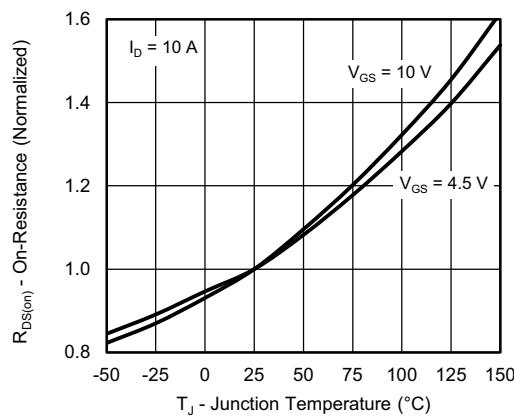
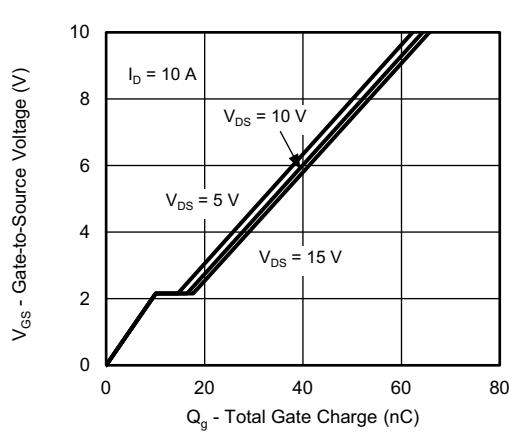
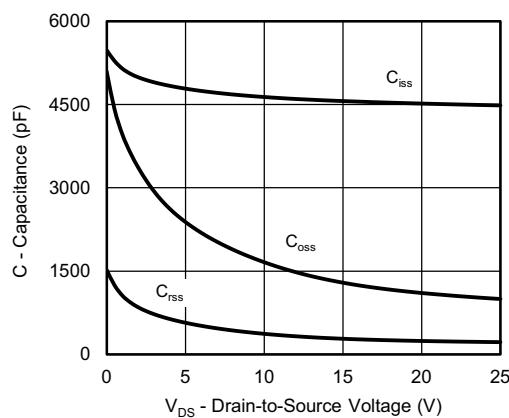
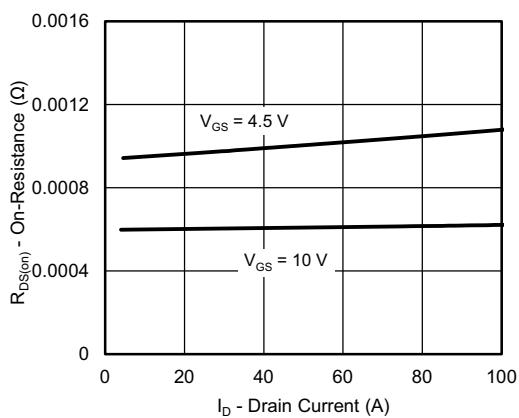
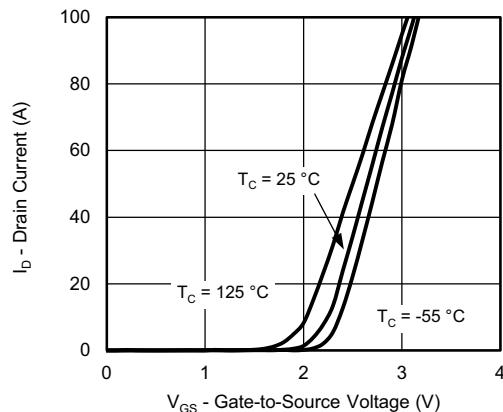
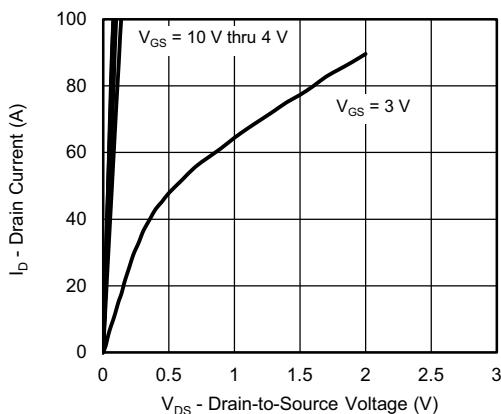
CHANNEL-1 TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)


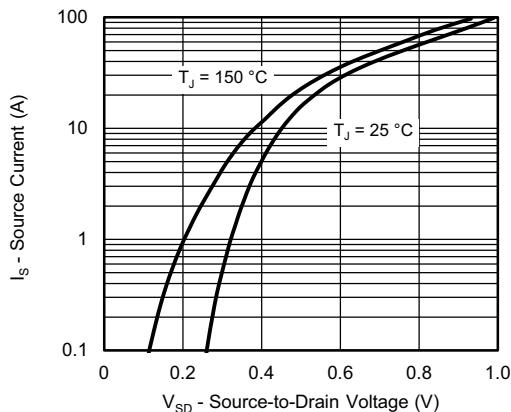
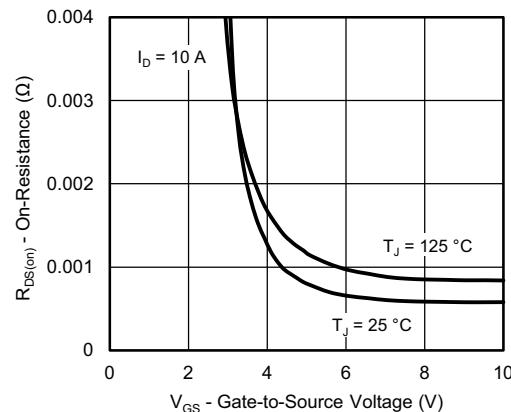
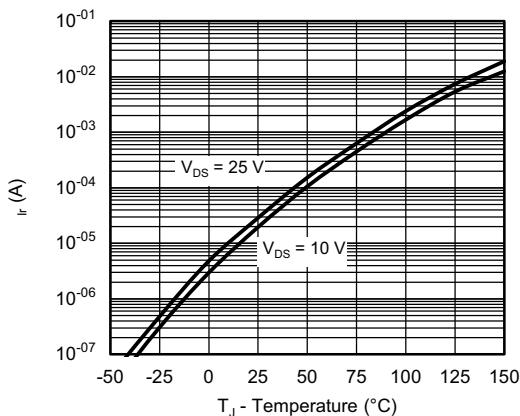
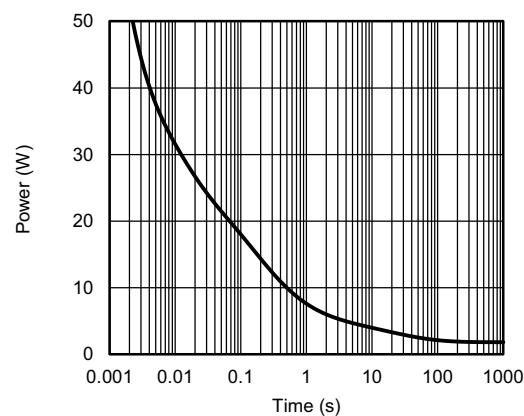
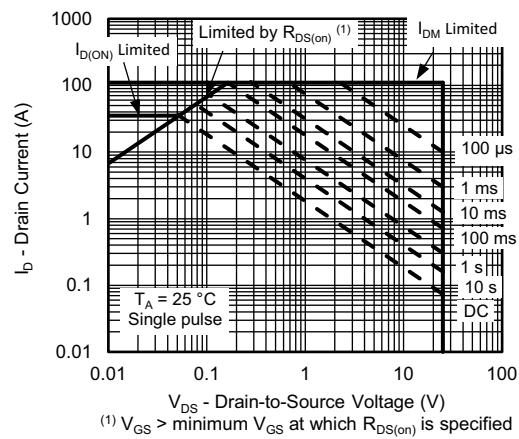
CHANNEL-1 TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

Source-Drain Diode Forward Voltage

On-Resistance vs. Gate-to-Source Voltage

Threshold Voltage

Single Pulse Power, Junction-to-Ambient

Safe Operating Area, Junction-to-Ambient

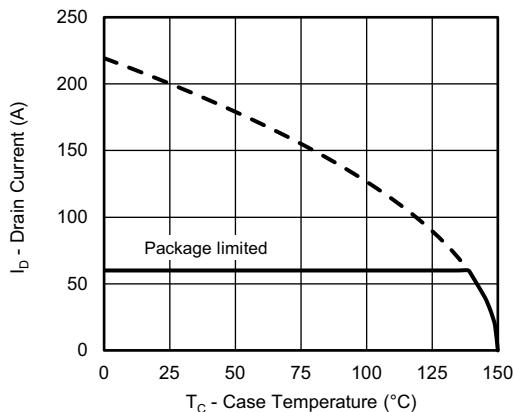
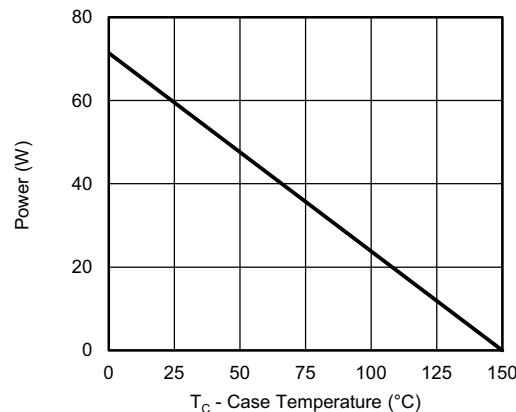
CHANNEL-1 TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

Current Derating^a

Power, Junction-to-Case
Note

- a. The power dissipation P_D is based on T_J max. = 150 °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit

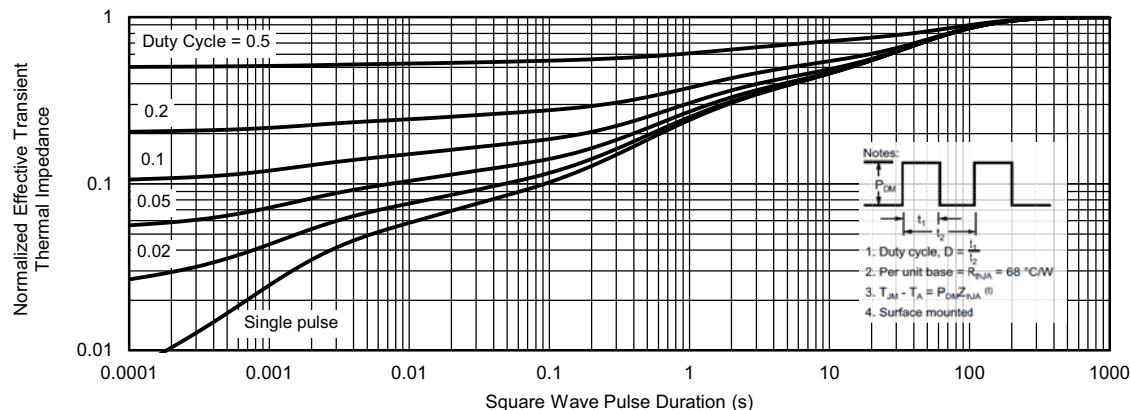
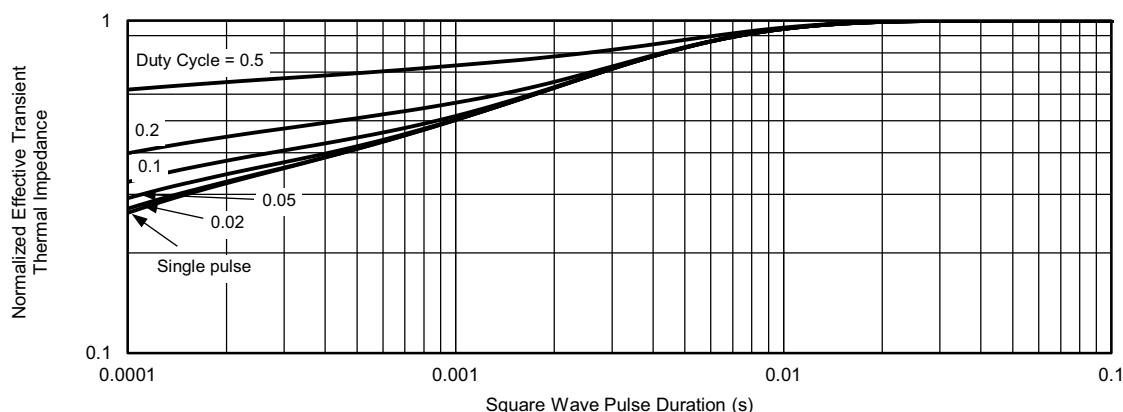
CHANNEL-1 TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)


CHANNEL-2 TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)


CHANNEL-2 TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

Source-Diode Forward Voltage

On-Resistance vs. Gate-to-Source Voltage

Reverse Current (Schottky)

Single Pulse Power, Junction-to-Ambient

Safe Operating Area, Junction-to-Ambient

CHANNEL-2 TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

Current Derating ^a

Power, Junction-to-Case
Note

- a. The power dissipation P_D is based on T_J max. = 150 °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit

CHANNEL-2 TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

Normalized Thermal Transient Impedance, Junction-to-Ambient

Normalized Thermal Transient Impedance, Junction-to-Case

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